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HIGH-SPEED 3.3V 256/128K x 18 SYNCHRONOUS DUAL-PORT STATIC RAM WITH 3.3V OR 2.5V INTERFACE

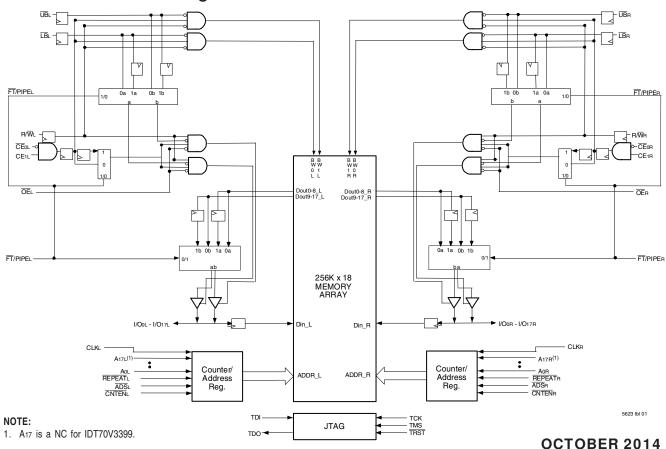
IDT70V3319/99S

Features:

- True Dual-Port memory cells which allow simultaneous access of the same memory location
- High-speed data access
 - Commercial: 3.6ns (166MHz)/4.2ns (133MHz) (max.)
 - Industrial: 4.2ns (133MHz) (max.)
- Selectable Pipelined or Flow-Through output mode
 - Due to limited pin count PL/FT option is not supported on the 128-pin TQFP package. Device is pipelined outputs only on each port.
- Counter enable and repeat features
- Dual chip enables allow for depth expansion without additional logic
- Full synchronous operation on both ports
 - 6ns cycle time, 166MHz operation (6Gbps bandwidth)
 - Fast 3.6ns clock to data out
 - 1.7ns setup to clock and 0.5ns hold on all control, data, and address inputs @ 166MHz
 - Data input, address, byte enable and control registers

- Self-timed write allows fast cycle time
- Separate byte controls for multiplexed bus and bus matching compatibility
- Dual Cycle Deselect (DCD) for Pipelined Output mode
- LVTTL- compatible, single 3.3V (±150mV) power supply for core
- LVTTL compatible, selectable 3.3V (±150mV) or 2.5V (±100mV) power supply for I/Os and control signals on each port
- Industrial temperature range (-40°C to +85°C) is available at 133MHz.
- Available in a 128-pin Thin Quad Flatpack, 208-pin fine pitch Ball Grid Array, and 256-pin Ball Grid Array
- Supports JTAG features compliant to IEEE 1149.1
 - Due to limited pin count, JTAG is not supported on the 128-pin TQFP package
- Green parts available, see ordering information

Functional Block Diagram



Description:

The IDT70V3319/99 is a high-speed 256/128K x 18 bit synchronous Dual-Port RAM. The memory array utilizes Dual-Port memory cells to allow simultaneous access of any address from both ports. Registers on control, data, and address inputs provide minimal setup and hold times. The timing latitude provided by this approach allows systems to be designed with very short cycle times. With an input data register, the IDT70V3319/99 has been optimized for applications having unidirectional

or bidirectional data flow in bursts. An automatic power down feature, controlled by $\overline{\text{CE}}$ 0 and CE_1 , permits the on-chip circuitry of each port to enter a very low standby power mode.

The 70V3319/99 can support an operating voltage of either 3.3V or 2.5V on one or both ports, controllable by the OPT pins. The power supply for the core of the device (VDD) remains at 3.3V.

Pin Configuration(1,2,3,4,5)

	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1
Α	Vss	NC	OPTL	AoL	A 4L	CNTENL	CLKL	V _{DD}	NC	AsL	A12L	A _{16L}	NC	TDO	Vss	NC	I/O ₉ L
В	NC	I/O ₈ L	VDDQR	Vss	A1L	A ₅ L	ĀDS _L	Vss	Œ₀L	NC	A9L	A13L	A _{17L} (1)	TDI	NC	Vss	NC
С	Vss	NC	I/O ₈ R	V _{DD}	A ₂ L	A 6L	R/WL	Vss	CE ₁ L	ŪBL	A _{10L}	A ₁₄ L	NC	PIPE/FTL	VDDQR	I/O ₉ R	VDDQL
D	I/O7R	I/O7L	VDDQL	NC	V _{DD}	Азь	REPEATL	ŌĒL	V _{DD}	ΪΒι	A7L	A _{11L}	A 15L	NC	I/O _{10L}	Vss	NC
E	NC	Vss	NC	I/O ₆ L										I/O10R	VDDQR	NC	I/O11L
F	VDDQR	NC	I/O ₆ R	Vss										Vss	NC	I/O11R	VDDQL
G	NC	I/O ₅ L	VDDQL	NC										NC	I/O12L	Vss	NC
Н	I/O _{5R}	Vss	NC	V _{DD}			-		319/				•	I/O12R	VDDQR	NC	V _{DD}
R J	VDDQR	Vss	V _{DD}	Vss				3 (6)	-208	BI				Vss	Vss	V _{DD}	VDDQL
ĸ	Vss	I/O _{4R}	VDDQL	I/O3R			١		Pin fp					Vss	I/O13R	Vss	I/O _{14R}
L	I/O ₄ L	Vss	I/O3L	NC						•				I/O13L	VDDQR	I/O14L	NC
R M	VDDQR	I/O ₂ R	NC	Vss										Vss	I/O _{15R}	NC	VDDQL
N	I/O ₂ L	NC	VDDQL	I/O _{1R}									•	I/O _{15L}	NC	Vss	NC
Р	NC	Vss	I/O1L	NC	A 4R	<u>CNTEN</u> _R	CLKR	V _{DD}	NC	A ₈ R	A ₁₂ R	A _{16R}	TRST	NC	VDDQR	I/O _{16L}	I/O _{16R}
R R	VDDQR	I/Oor	VDDQL	Vss	A _{1R}	A 5R	ĀDSR	Vss	Œ0R	NC	A9R	A13R	A _{17R} (1)	TCK	I/O17R	NC	Vss
Т	NC	Vss	NC	Vss	A 2R	A ₆ R	R/WR	Vss	CE _{1R}	ŪBR	A _{10R}	A ₁₄ R	NC	TMS	VDDQL	I/O ₁₇ L	NC
U	I/Ool	NC	OPTR	V _{DD}	Aor	Азп	REPEATR	ŌĒR	V _{DD}	LBR	A 7R	A 11R	A _{15R}	NC	PIPE/FT _R	NC	Vss

5623 drw 02c

- 1. A₁₇ is a NC for IDT70V3399.
- 2. All VDD pins must be connected to 3.3V power supply.
- 3. All VDDQ pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to VIH (3.3V), and 2.5V if OPT pin for that port is set to VIL (0V).
- 4. All Vss pins must be connected to ground supply.
- 5. Package body is approximately 15mm x 15mm x 1.4mm with 0.8mm ball pitch.
- 6. This package code is used to reference the package diagram.
- 7. This text does not indicate orientation of the actual part-marking.

Pin Configuration(1,2,3,4,5) (con't.)

70V3319/99BC BC-256(6)

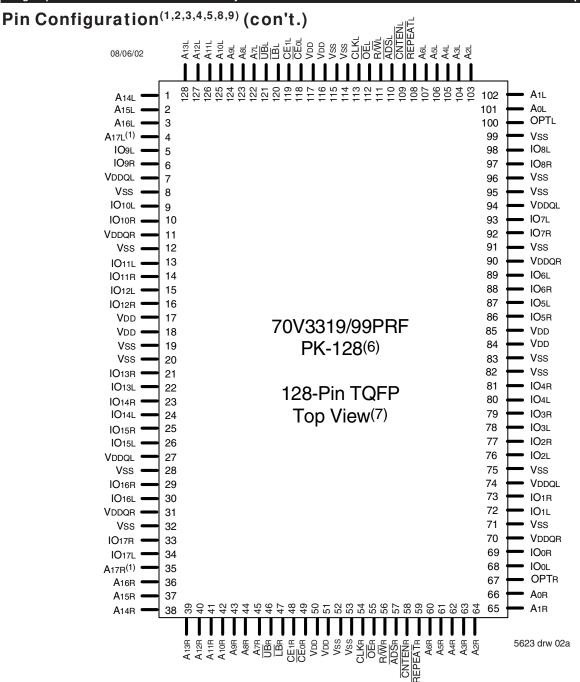
256-Pin BGA Top View(7)

08/01/02

A1	A2	A3	A4	A5	A6	A7	A8	A9	A10	A11	A12	A13	A14	A15	A16
NC	TDI	NC	A17L ⁽¹⁾	A 14L	A11L	A 8L	NC	CE1L	OEL	CNTENL	A 5L	A 2L	A 0L	NC	NC
NC	NC	TDO	NC	B5 A15L	B6 A 12L	B7 A 9L	B8 UBL	B9 CE ₀ L	B10 R/WL	B11 REPEATL	B12 A4L	B13 A 1L	B14 VDD	B15 NC	B16 NC
C1	C2	C3	C4	C5	C6	C7	C8	C9	C10	C11	C12	C13	C14	C15	C16
NC	I/O9L	Vss	A 16L	A 13L	A10L	A 7L	NC	LBL	CLKL	ADSL	A 6L	A 3L	OPTL	NC	I/O8L
D1	D2	D3	D4	D5	D6	D7	D8	D9	D10	D11	D12	D13	D14	D15	D16
NC	I/O9R	NC	PIPE/FTL	Vddql	VDDQL	VDDQR	VDDQR	Vddql	VDDQL	VDDQR	VDDQR	VDD	NC	NC	I/O8R
E1	E2	E3	E4	E5	E6	E7	E8	E9	E10	E11	E12	E13	E14	E15	E16
I/O10R	I/O10L	NC	VDDQL	Vdd	VDD	Vss	Vss	Vss	Vss	VDD	VDD	VDDQR	NC	I/O7L	I/O7R
F1	F2	F3	F4	F5	F6	F7	F8	F9	F10	F11	F12	F13	F14	F15	F16
I/O11L	NC	I/O11R	VDDQL	Vdd	Vss	Vss	Vss	Vss	Vss	Vss	VDD	VDDQR	I/O6R	NC	I/O6L
G1	G2	G3	G4	G5	G6	G7	G8	G9	G10	G11	G12	G13	G14	G15	G16
NC	NC	I/O12L	VDDQR	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vss	VDDQL	I/O5L	NC	NC
H1	H2	H3	H4	H5	H6	H7	H8	H9	H10	H11	H12	H13	H14	H15	H16
NC	I/O12R	NC	VDDQR	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vss	VDDQL	NC	NC	I/O5R
J1	J2	J3	J4	J5	J6	J7	J8	J9	J10	J11	J12	J13	J14	J15	J16
I/O13L	I/O14R	I/O13R	VDDQL	Vss	V SS	V SS	V SS	V SS	Vss	Vss	Vss	VDDQR	I/O4R	I/О 3R	I/O4L
K1	K2	K3	K4	K5	K6	K7	K8	K9	K10	K11	K12	K13	K14	K15	К16
NC	NC	I/O14L	Vddql	Vss	Vss	Vss	Vss	Vss	Vss	Vss	Vss	VDDQR	NC	NC	I/ОзL
L1	L2	L3	L4	L5	L6	L7	L8	L9	L10	L11	L12	L13	L14	L15	L16
I/O15L	NC	I/O15R	VDDQR	VDD	Vss	Vss	Vss	Vss	Vss	Vss	VDD	Vddql	I/ O 2L	NC	I/O2R
M1	M2	M3	M4	M5	M6	M7	M8	м9	M10	M11	M12	M13	M14	M15	M16
I/O16R	I/O16L	NC	VDDQR	VDD	VDD	Vss	Vss	Vss	Vss	VDD	VDD	VDDQL	I/O1R	I/O1L	NC
N1	N2	N3	N4	N5	N6	N7	N8	N9	N10	N11	N12	N13	N14	N15	N16
NC	I/O17R	NC	PIPE/FTR	VDDQR	VDDQR	Vddql	Vddql	V DDQR	VDDQR	VDDQL	VDDQL	V DD	NC	I/O0R	NC
P1	P2	P3	P4	P5	P6	P7	P8	P9	P10	P11	P12	P13	P14	P15	P16
NC	I/O17L	TMS	A 16R	A 13R	A 10R	A 7R	NC	LBR	CLKR	ADSR	A 6R	A 3R	NC	NC	I/ O 0L
R1	R2	R3	R4	R5	R6	R7	R8	R9	R10	R11	R12	R13	R14	R15	R16
NC	NC	TRST	NC	A 15R	A 12R	A 9R	UBr	CE0R	R/WR	REPEATR	A 4R	A 1R	OPTR	NC	NC
T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13	T14	T15	T16
NC	TCK	NC	A 17R ⁽¹⁾	A 14R	A 11R	A 8R	NC	CE1R	OEr	CNTENR	A 5R	A 2R	A 0R	NC	NC

5623 drw 02d

- 1. A₁₇ is a NC for IDT70V3399.
- 2. All VDD pins must be connected to 3.3V power supply.
- 3. All VDDQ pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to VIH (3.3V), and 2.5V if OPT pin for that port is set to VIL (0V).
- 4. All Vss pins must be connected to ground supply.
- 5. Package body is approximately 17mm x 17mm x 1.4mm, with 1.0mm ball-pitch.
- 6. This package code is used to reference the package diagram.7. This text does not indicate orientation of the actual part-marking.



- 1. A₁₇ is a NC for IDT70V3399.
- 2. All VDD pins must be connected to 3.3V power supply.
- 3. All VDDQ pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to VIH (3.3V), and 2.5V if OPT pin for that port is set to VIL (0V).
- 4. All Vss pins must be connected to ground supply.
- 5. Package body is approximately 14mm x 20mm x 1.4mm.
- 6. This package code is used to reference the package diagram.
- 7. This text does not indicate orientation of the actual part-marking.
- 8. PIPE/FT option in PK-128 is not supported due to limitation in pin count. Device is pipelined outputs only on each port.
- 9. Due to the limited pin count, JTAG is not supported in the PK-128 package.

Pin Names

Left Port	Right Port	Names
CEOL, CE1L	Œ0R, CE1R	Chip Enables ⁽⁶⁾
R/WL	R/WR	Read/Write Enable
ŌĒL	ŌĒR	Output Enable
A0L - A17L ⁽¹⁾	A0R - A17R ⁽¹⁾	Address
I/O0L - I/O17L	I/O0R - I/O17R	Data Input/Output
CLKL	CLKR	Clock
PIPE/FTL ⁽⁵⁾	PIPE/FTR ⁽⁵⁾	Pipeline/Flow-Through
AD SL	ĀDSR	Address Strobe Enable
CNTENL	CNTENR	Counter Enable
REPEATL	REPEATR	Counter Repeat ⁽⁴⁾
ŪB∟	UB R	Upper Byte Enable (I/O ₉ -I/O ₁₇) ⁽⁶⁾
IB L	LB R	Lower Byte Enable (I/Oo-I/O8) ⁽⁶⁾
VDDQL	VDDQR	Power (I/O Bus) (3.3V or 2.5V)(2)
OPTL	OPTR	Option for selecting VDDqx ^(2,3)
	VDD	Power (3.3V) ⁽²⁾
	Vss	Ground (0V)
	TDI	Test Data Input
	TDO	Test Data Output
	TCK	Test Logic Clock (10MHz)
	TMS	Test Mode Select
-	TRST	Reset (Initialize TAP Controller)

- 1. A₁₇ is a NC for IDT70V3399.
- VDD, OPTx, and VDDQx must be set to appropriate operating levels prior to applying inputs on the I/Os and controls for that port.
- 3. OPTx selects the operating voltage levels for the I/Os and controls on that port. If OPTx is set to VIH (3.3V), then that port's I/Os and controls will operate at 3.3V levels and VDDQX must be supplied at 3.3V. If OPTx is set to VIL (0V), then that port's I/Os and address controls will operate at 2.5V levels and VDDQX must be supplied at 2.5V. The OPT pins are independent of one another—both ports can operate at 3.3V levels, both can operate at 2.5V levels, or either can operate at 3.3V with the other at 2.5V.
- When REPEATx is asserted, the counter will reset to the last valid address loaded via ADSx.
- PIPE/FT option in PK-128 package is not supported due to limitation in pin count.
 Device is pipelined output mode only on each port.
- Chip Enables and Byte Enables are double buffered when PL/FT = ViH, i.e., the signals take two cycles to deselect.

5623 tb102

Truth Table I—Read/Write and Enable Control(1,2,3)

ŌĒ	CLK	Œ	CE ₁	ŪB	ĪΒ	R/W	Upper Byte I/O9-17	Lower Byte I/O ₀₋₈	MODE
Х	1	Н	Х	Χ	Х	Х	High-Z	High-Z	Deselected-Power Down
Х	1	Х	L	Х	Х	Х	High-Z	High-Z	Deselected-Power Down
Х	1	L	Η	Н	Н	Х	High-Z	High-Z	Both Bytes Deselected
Х	1	L	Η	Н	L	L	High-Z	Din	Write to Lower Byte Only
Х	1	L	Η	L	Н	L	Din	High-Z	Write to Upper Byte Only
Х	1	L	Η	L	L	L	Din	Din	Write to Both Bytes
L	1	L	Н	Н	L	Н	High-Z	Dоит	Read Lower Byte Only
L	1	L	Η	L	Н	Η	Douт	High-Z	Read Upper Byte Only
L	1	L	Н	L	L	Н	Douт	Dоит	Read Both Bytes
Н	1	L	Н	L	L	Х	High-Z	High-Z	Outputs Disabled

NOTES:

- 1. "H" = VIH, "L" = VIL, "X" = Don't Care.
- 2. \overline{ADS} , \overline{CNTEN} , $\overline{REPEAT} = X$.
- 3. $\overline{\text{OE}}$ is an asynchronous input signal.

Truth Table II—Address Counter Control^(1,2)

		· · · · · ·	4410					
External Address	Previous Internal Address	Internal Address Used	CLK	ĀDS	CNTEN	REPEAT ⁽⁶⁾	I/O ⁽³⁾	MODE
Х	Х	An	1	Χ	Χ	L ⁽⁴⁾	Dvo(0)	Counter Reset to last valid ADS load
An	Х	An	1	L ⁽⁴⁾	Х	Н	Dvo (n)	External Address Used
An	Ар	Ар	1	Н	Н	Н	Dvo(p)	External Address Blocked—Counter disabled (Ap reused)
Х	Ар	Ap + 1	1	Н	L ⁽⁵⁾	Н	Di/o(p+1)	Counter Enabled—Internal Address generation

NOTES: 5623 tbl 03

- 1. "H" = VIH, "L" = VIL, "X" = Don't Care.
- 2. Read and write operations are controlled by the appropriate setting of R/ \overline{W} , \overline{CE}_0 , CE1, \overline{UB} , \overline{LB} and \overline{OE} .
- 3. Outputs configured in flow-through output mode: if outputs are in pipelined mode the date out will be delayed by one cycle.
- 4. ADS and REPEAT are independent of all other memory control signals including CEo, CE1 and UB, LB.
- 5. The address counter advances if $\overline{\text{CNTEN}} = \text{V}_{\text{IL}}$ on the rising edge of CLK, regardless of all other memory control signals including $\overline{\text{CE}}_0$, CE₁, $\overline{\text{UB}}$, $\overline{\text{LB}}$.
- 6. When REPEAT is asserted, the counter will reset to the last valid address loaded via ADS. This value is not set at power-up: a known location should be loaded via ADS during initialization if desired. Any subsequent ADS access during operations will update the REPEAT address location.

Recommended Operating Temperature and Supply Voltage⁽¹⁾

Grade	Ambient Temperature	GND	VDD
Commercial	0°C to +70°C	0V	3.3V <u>+</u> 150mV
Industrial	-40°C to +85°C	0V	3.3V <u>+</u> 150mV

NOTES:

5623 tbl 04

1. This is the parameter TA. This is the "instant on" case temperature.

Absolute Maximum Ratings(1)

Symbol	Rating	Commercial & Industrial	Unit
VTERM ⁽²⁾	Terminal Voltage with Respect to GND	-0.5 to +4.6	V
TBIAS ⁽³⁾	Temperature Under Bias	-55 to +125	°C
Tstg	Storage Temperature	-65 to +150	°C
Тли	Junction Temperature	+150	°C
Іоит	DC Output Current	50	mA

NOTES: 5623 101 06

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- VTERM must not exceed VDD + 150mV for more than 25% of the cycle time or 4ns maximum, and is limited to ≤ 20mA for the period of VTERM ≥ VDD + 150mV.
- 3. Ambient Temperature Under Bias. No AC Conditions. Chip Deselected.

Recommended DC Operating Conditions with VDDQ at 2.5V

Symbol	Parameter	Min.	Тур.	Max.	Unit
VDD	Core Supply Voltage	3.15	3.3	3.45	٧
VDDQ	I/O Supply Voltage ⁽³⁾	2.4	2.5	2.6	٧
Vss	Ground	0	0	0	٧
VIH	Input High Voltage (Address & Control Inputs)	1.7	-	VDDQ + 100mV ⁽²⁾	V
VIH	Input High Voltage - I/O ⁽³⁾	1.7		VDDQ + 100mV ⁽²⁾	٧
VIL	Input Low Voltage	-0.3 ⁽¹⁾		0.7	٧

NOTES:

5623 tb1 05a

- 1. Undershoot of $V_{IL \ge}$ -1.5V for pulse width less than 10ns is allowed.
- 2. VTERM must not exceed VDDQ + 100mV.
- To select operation at 2.5V levels on the I/Os and controls of a given port, the OPT pin for that port must be set to VIL (0V), and VDDQX for that port must be supplied as indicated above.

Recommended DC Operating Conditions with VDDQ at 3.3V

Symbol	Parameter	Min.	Тур.	Max.	Unit
VDD	Core Supply Voltage	3.15	3.3	3.45	٧
VDDQ	I/O Supply Voltage ⁽³⁾	3.15	3.3	3.45	٧
Vss	Ground	0	0	0	٧
VIH	Input High Voltage (Address & Control Inputs) ⁽³⁾	2.0		VDDQ + 150mV ⁽²⁾	V
V⊩	Input High Voltage - I/O(3)	2.0	_	VDDQ + 150mV ⁽²⁾	٧
VIL	Input Low Voltage	-0.3 ⁽¹⁾	_	0.8	٧

NOTES:

5623 tbl 05b

- 1. Undershoot of $V_{IL \ge}$ -1.5V for pulse width less than 10ns is allowed.
- 2. VTERM must not exceed VDDQ + 150mV.
- To select operation at 3.3V levels on the I/Os and controls of a given port, the OPT pin for that port must be set to ViH (3.3V), and VDDOX for that port must be supplied as indicated above.

Capacitance⁽¹⁾(TA = +25°C, F = 1.0MHz)

Symbol	Parameter	Conditions ⁽²⁾	Max.	Unit
CIN	Input Capacitance	VIN = 3dV	8	pF
Соит ⁽³⁾	Output Capacitance	Vout = 3dV	10.5	pF

5623 tbl 07

NOTES:

- These parameters are determined by device characterization, but are not production tested.
- 2. 3dV references the interpolated capacitance when the input and output switch from 0V to 3V or from 3V to 0V.
- 3. Cout also references CI/o.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range (VDD = 3.3V ± 150mV)

			70V33	19/99S	
Symbol	Parameter	Test Conditions	Min. Max.		Unit
IIII	Input Leakage Current ⁽¹⁾	VDDQ = Max., VIN = 0V to VDDQ	_	10	μA
llrol	Output Leakage Currentt ⁽¹⁾	$\overline{CE}_0 = VIH \text{ or } CE_1 = VIL, VOUT = 0V \text{ to } VDDQ$	_	10	μA
Vol (3.3V)	Output Low Voltage ⁽²⁾	IOL = +4mA, VDDQ = Min.	_	0.4	٧
Voн (3.3V)	Output High Voltage ⁽²⁾	IOH = -4mA, VDDQ = Min.	2.4	_	٧
Vol (2.5V)	Output Low Voltage ⁽²⁾	IOL = +2mA, VDDQ = Min.	_	0.4	٧
Voн (2.5V)	Output High Voltage ⁽²⁾	Юн = -2mA, VDDQ = Min.	2.0	_	٧

NOTE:

5623 tbl 08

- 1. At $VDD \le 2.0V$ leakages are undefined.
- 2. VDDQ is selectable (3.3V/2.5V) via OPT pins. Refer to p.5 for details.

5623 tbl 09

DC Electrical Characteristics Over the Operating
Temperature and Supply Voltage Range⁽³⁾ (VDD = 3.3V ± 150mV)

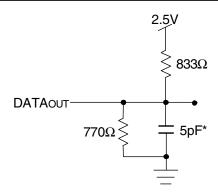
						9/99S166 I Only	Co	9/99\$133 m'l Ind	
Symbol	Parameter	Test Condition	Version	Version		Typ. ⁽⁴⁾ Max.		Max.	Unit
ldd	Dynamic Operating	CEL and CER= VIL,	COM'L	S	370	500	320	400	mA
	Current (Both Ports Active)	Outputs Disabled, f = fMAX ⁽¹⁾	IND	S		_	320	480	
ISB1	Standby Current	CEL = CER = VIH,	COM'L	S	125	200	115	160	mA
	(Both Ports - TTL Level Inputs)	Outputs Disabled, f = fMAX ⁽¹⁾	IND	S		_	115	195	
ISB2	Standby Current (One Port - TTL	CE"A" = VIL and CE"B" = VIH(5)	COM'L	S	250	350	220	290	mA
	Level Inputs)	Active Port Outputs Disabled, f=fMAX ⁽¹⁾	IND	S			220	350	
ISB3	Full Standby Current (Both Ports - CMOS	Both Ports Outputs Disabled CEL and CER ≥ VDDQ - 0.2V,	COM'L	S	15	30	15	30	mA
	Level Inputs)	$VIN \ge VDDQ - 0.2V$ or $VIN \le 0.2V$, $f = 0^{(2)}$	IND	S			15	40	
ISB4	Full Standby Current (One Port - CMOS	$\overline{CE}^*A^* \le 0.2V$ and $\overline{CE}^*B^* \ge VDDQ - 0.2V^{(5)}$	COM'L	S	250	350	220	290	mA
	Level Inputs)	VIN \geq VDDQ - 0.2V or VIN \leq 0.2V Active Port, Outputs Disabled, f = fMAX ⁽¹⁾	IND	S			220	350	

- 1. At f = fmax, address and control lines (except Output Enable) are cycling at the maximum frequency clock cycle of 1/tcyc, using "AC TEST CONDITIONS" at input levels of GND to 3V.
- 2. f = 0 means no address, clock, or control lines change. Applies only to input at CMOS level standby.
- 3. Port "A" may be either left or right port. Port "B" is the opposite from port "A".
- 4. VDD = 3.3V, TA = 25°C for Typ, and are not production tested. IDD DC(f=0) = 120mA (Typ).
- 5. $\overline{CE}x = V_{IL} \text{ means } \overline{CE}_{0}x = V_{IL} \text{ and } CE_{1}x = V_{IH}$
 - $\overline{CE}x = VIH \text{ means } \overline{CE}_0x = VIH \text{ or } CE_1x = VIL$
 - $\overline{\text{CEx}} \leq 0.2 \text{V}$ means $\overline{\text{CE}} \text{ox} \leq 0.2 \text{V}$ and $\text{CE} \text{ix} \geq \text{V}_{\text{DDQ}} 0.2 \text{V}$
 - CEx > VDDQ 0.2V means CEox > VDDQ 0.2V or CE1x 0.2V
 - "X" represents "L" for left port or "R" for right port.

AC Test Conditions (VDDQ - 3.3V/2.5V)

AO ICST ODIIGITIONS	V DDQ - 3.3 V/2.3 V)				
Input Pulse Levels (Address & Controls)	GND to 3.0V/GND to 2.4V				
Input Pulse Levels (I/Os)	GND to 3.0V/GND to 2.4V				
Input Rise/Fall Times	2ns				
Input Timing Reference Levels	1.5V/1.25V				
Output Reference Levels	1.5V/1.25V				
Output Load	Figures 1 and 2				

5623 tbl 10



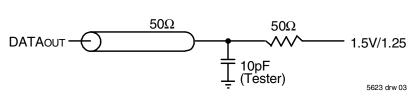


Figure 1. AC Output Test load.

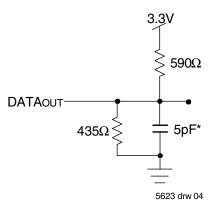


Figure 2. Output Test Load (For tckLz, tckHz, toLz, and toHz).
*Including scope and jig.

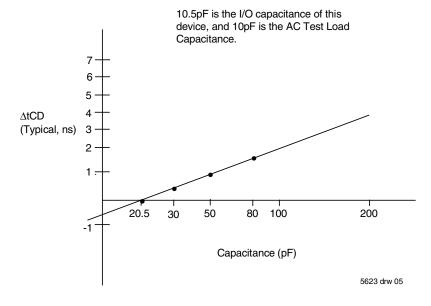


Figure 3. Typical Output Derating (Lumped Capacitive Load).

AC Electrical Characteristics Over the Operating Temperature Range (Read and Write Cycle Timing) $^{(2,3)}$ (VDD = 3.3V ± 150mV, TA = 0°C to +70°C)

	and Write Cycle Timing) (VDD = 3.3V ± 150mV	70V331	70V3319/99S166 Com'l Only		70V3319/99S133 Com'l & Ind			
Symbol	Parameter	Min.	Max.	Min.	Max.	Unit		
tcyc1	Clock Cycle Time (Flow-Through) ⁽¹⁾	20		25		ns		
tCYC2	Clock Cycle Time (Pipelined) ⁽¹⁾	6		7.5	_	ns		
tCH1	Clock High Time (Flow-Through) ⁽¹⁾	6		7	_	ns		
tCL1	Clock Low Time (Flow-Through) ⁽¹⁾	6		7		ns		
tCH2	Clock High Time (Pipelined) ⁽²⁾	2.1		2.6		ns		
tCL2	Clock Low Time (Pipelined) ⁽¹⁾	2.1		2.6		ns		
tsa	Address Setup Time	1.7		1.8	_	ns		
tha	Address Hold Time	0.5		0.5		ns		
tsc	Chip Enable Setup Time	1.7		1.8	_	ns		
thc	Chip Enable Hold Time	0.5		0.5		ns		
tsB	Byte Enable Setup Time	1.7		1.8		ns		
tнв	Byte Enable Hold Time	0.5		0.5		ns		
tsw	R/W Setup Time	1.7		1.8		ns		
tHW	R/W Hold Time	0.5		0.5		ns		
tsp	Input Data Setup Time	1.7		1.8		ns		
tHD	Input Data Hold Time	0.5		0.5		ns		
tsad	ADS Setup Time	1.7		1.8		ns		
thad	ADS Hold Time	0.5		0.5		ns		
tscn	CNTEN Setup Time	1.7		1.8		ns		
tHCN	CNTEN Hold Time	0.5		0.5		ns		
tsrpt	REPEAT Setup Time	1.7		1.8		ns		
thrpt	REPEAT Hold Time	0.5		0.5		ns		
toE	Output Enable to Data Valid	_	4.0		4.2	ns		
toLZ	Output Enable to Output Low-Z	1		1		ns		
tonz	Output Enable to Output High-Z	1	3.6	1	4.2	ns		
tCD1	Clock to Data Valid (Flow-Through)(1)	_	12		15	ns		
tCD2	Clock to Data Valid (Pipelined) ⁽¹⁾	_	3.6	_	4.2	ns		
toc	Data Output Hold After Clock High	1		1		ns		
tckhz	Clock High to Output High-Z		3	1	3	ns		
tcklz	Clock High to Output Low-Z			1		ns		
Port-to-Port D	Port-to-Port Delay							
tco	Clock-to-Clock Offset	5		6		ns		

NOTES

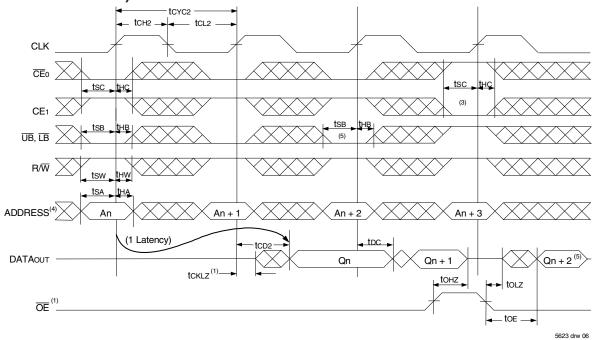
5623 tbl 11

^{1.} The Pipelined output parameters (tcyc2, tcp2) apply to either or both left and right ports when FT/PIPEx = VIH. Flow-through parameters (tcyc1, tcp1) apply when FT/PIPE = VIL for that port.

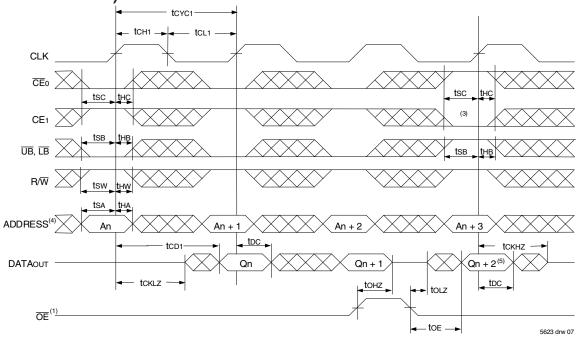
^{2.} All input signals are synchronous with respect to the clock except for the asynchronous Output Enable (OE) and FT/PIPE. FT/PIPE should be treated as a DC signal, i.e. steady state during operation.

^{3.} These values are valid for either level of VDDQ (3.3V/2.5V). See page 5 for details on selecting the desired operating voltage levels for each port.

Timing Waveform of Read Cycle for Pipelined Operation $(\overline{FT}/PIPE'x' = VIH)^{(2)}$

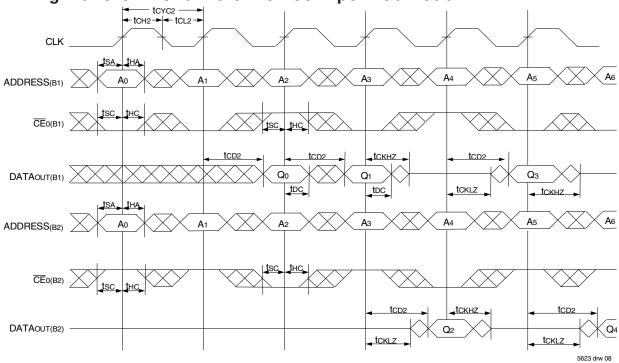


Timing Waveform of Read Cycle for Flow-through Output $(\overline{FT}/PIPE"x" = VIL)^{(2,6)}$

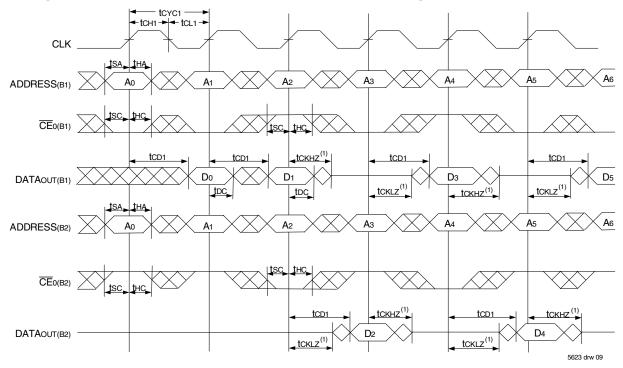


- 1. $\overline{\text{OE}}$ is asynchronously controlled; all other inputs are synchronous to the rising clock edge.
- 2. $\overline{ADS} = VIL$, \overline{CNTEN} and $\overline{REPEAT} = VIH$.
- 3. The output is disabled (High-Impedance state) by CE₀ = VIH, CE₁ = VIL, UB, LB = VIH following the next rising edge of the clock. Refer to Truth Table 1.
- 4. Addresses do not have to be accessed sequentially since $\overline{ADS} = V_{IL}$ constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 5. If $\overline{\sf UB}$, $\overline{\sf LB}$ was HIGH, then the appropriate Byte of DATAout for Qn + 2 would be disabled (High-Impedance state).
- 6. "x" denotes Left or Right port. The diagram is with respect to that port.

Timing Waveform of a Multi-Device Pipelined Read^(1,2)

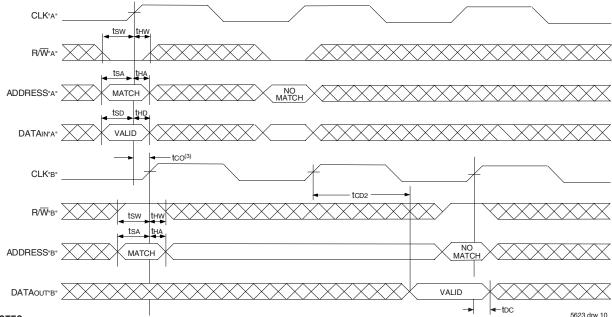


Timing Waveform of a Multi-Device Flow-Through Read^(1,2)



- B1 Represents Device #1; B2 Represents Device #2. Each Device consists of one IDT70V3319/99 for this waveform, and are setup for depth expansion in this example. ADDRESS(B1) = ADDRESS(B2) in this situation.
- 2. $\overline{\text{UB}}$, $\overline{\text{LB}}$, $\overline{\text{OE}}$, and $\overline{\text{ADS}}$ = VIL; CE1(B1), CE1(B2), R/W, $\overline{\text{CNTEN}}$, and $\overline{\text{REPEAT}}$ = VIH.

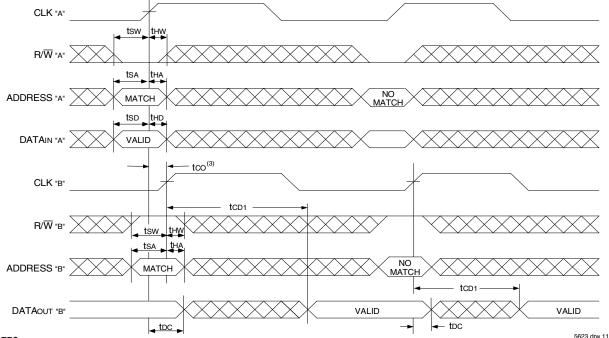
Timing Waveform of Left Port Write to Pipelined Right Port Read(1,2,4)



NOTES:

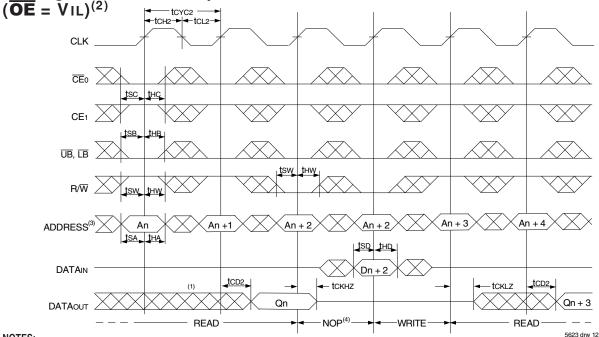
- 1. \overline{CE}_0 , \overline{UB} , \overline{LB} , and $\overline{ADS} = VIL$; \overline{CE}_1 , \overline{CNTEN} , and $\overline{REPEAT} = VIH$.
- 2. $\overline{OE} = V_{IL}$ for Port "B", which is being read from. $\overline{OE} = V_{IH}$ for Port "A", which is being written to.
- If tco ≤ minimum specified, then data from Port "B" read is not valid until following Port "B" clock cycle (ie, time from write to valid read on opposite port will be tco + 2 tcyc2 + tcp2). If tco > minimum, then data from Port "B" read is available on first Port "B" clock cycle (ie, time from write to valid read on opposite port will be tco + tcyc2 + tcp2).
- 4. All timing is the same for Left and Right ports. Port "A" may be either Left or Right port. Port "B" is the opposite of Port "A"

Timing Waveform with Port-to-Port Flow-Through Read^(1,2,4)



- 1. $\overline{CE_0}$, \overline{UB} , \overline{LB} , and \overline{ADS} = VIL; CE₁, \overline{CNTEN} , and \overline{REPEAT} = VIH.
- 2. $\overline{OE} = V_{IL}$ for the Right Port, which is being read from. $\overline{OE} = V_{IH}$ for the Left Port, which is being written to.
- 3. If tco ≤ minimum specified, then data from Port "B" read is not valid until following Port "B" clock cycle (i.e., time from write to valid read on opposite port will be tco + tcyc + tcp1). If tco > minimum, then data from Port "B" read is available on first Port "B" clock cycle (i.e., time from write to valid read on opposite port will be tco + tcp1).
- 4. All timing is the same for both left and right ports. Port "A" may be either left or right port. Port "B" is the opposite of Port "A".

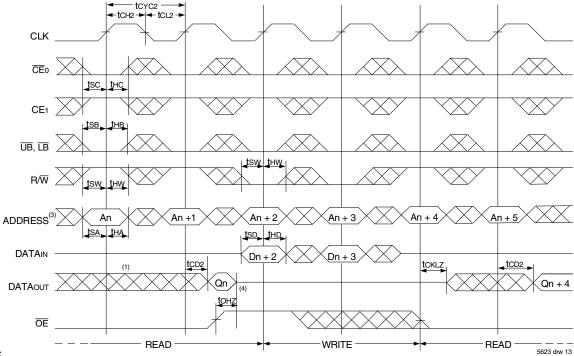
Timing Waveform of Pipelined Read-to-Write-to-Read



NOTES:

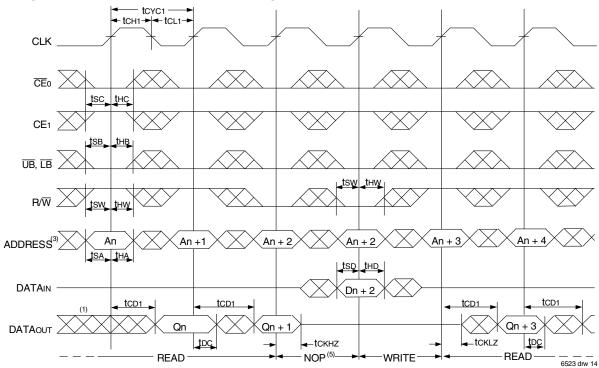
- 1. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
- CEo, UB, LB, and ADS = VIL; CE1, CNTEN, and REPEAT = VIH. "NOP" is "No Operation".
- 3. Addresses do not have to be accessed sequentially since ADS = ViL constantly loads the address on the rising edge of the CLK; numbers
- 4. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

Timing Waveform of Pipelined Read-to-Write-to-Read (OE Controlled)(2)

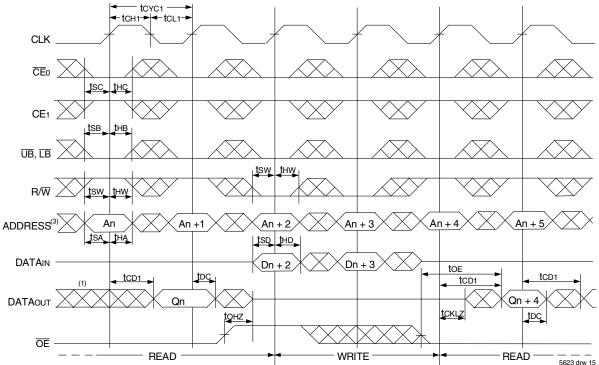


- Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
- 2. $\overline{CE_0}$, \overline{UB} , \overline{LB} , and \overline{ADS} = VIL; $\overline{CE_1}$, \overline{CNTEN} , and \overline{REPEAT} = VIH.
- Addresses do not have to be accessed sequentially since ADS = VIL constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 4. This timing does not meet requirements for fastest speed grade. This waveform indicates how logically it could be done if timing so allows.

Timing Waveform of Flow-Through Read-to-Write-to-Read (**OE** = VIL)⁽²⁾

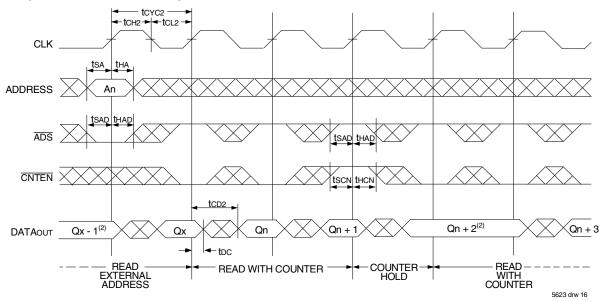


Timing Waveform of Flow-Through Read-to-Write-to-Read (**OE** Controlled)⁽²⁾

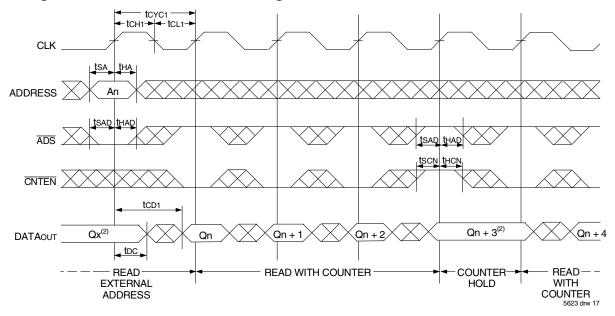


- 1. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
- 2. $\overline{\text{CE}}_0$, $\overline{\text{UB}}$, $\overline{\text{LB}}$, and $\overline{\text{ADS}}$ = V_{IL}; $\overline{\text{CE}}_1$, $\overline{\text{CNTEN}}$, and $\overline{\text{REPEAT}}$ = V_{IH}.
- 3. Addresses do not have to be accessed sequentially since $\overline{ADS} = V_{IL}$ constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 4. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

Timing Waveform of Pipelined Read with Address Counter Advance⁽¹⁾

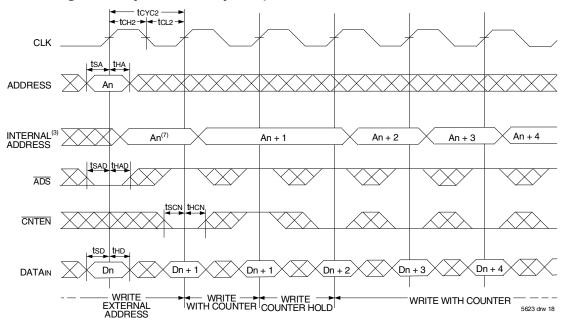


Timing Waveform of Flow-Through Read with Address Counter Advance (1)

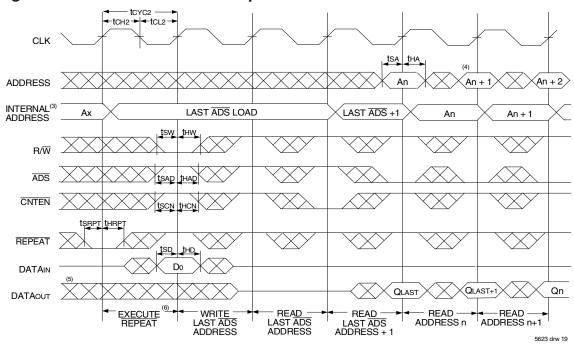


- 1. \overline{CE}_0 , \overline{OE} , \overline{UB} , \overline{LB} = VIL; CE1, R/W, and \overline{REPEAT} = VIH.
- 2. If there is no address change via $\overline{ADS} = V_{IL}$ (loading a new address) or $\overline{CNTEN} = V_{IL}$ (advancing the address), i.e. $\overline{ADS} = V_{IH}$ and $\overline{CNTEN} = V_{IH}$, then the data output remains constant for subsequent clocks.

Timing Waveform of Write with Address Counter Advance (Flow-through or Pipelined Inputs)⁽¹⁾



Timing Waveform of Counter Repeat⁽²⁾



- 1. \overline{CE}_0 , \overline{UB} , \overline{LB} , and $R/\overline{W} = V_{IL}$; CE_1 and $\overline{REPEAT} = V_{IH}$.
- 2. CE0, UB, LB = VIL; CE1 = VIH.
- 3. The "Internal Address" is equal to the "External Address" when $\overline{ADS} = VIL$ and equals the counter output when $\overline{ADS} = VIH$.
- 4. Addresses do not have to be accessed sequentially since $\overline{ADS} = V_{IL}$ constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 5. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
- 6. No dead cycle exists during REPEAT operation. A READ or WRITE cycle may be coincidental with the counter REPEAT cycle: Address loaded by last valid ADS load will be accessed. Extra cycles are shown here simply for clarification. For more information on REPEAT function refer to Truth Table II.
- 7. CNTEN = V_{IL} advances Internal Address from 'An' to 'An +1'. The transition shown indicates the time required for the counter to advance. The 'An +1'Address is written to during this cycle.

Functional Description

The IDT70V3319/99 provides a true synchronous Dual-Port Static RAM interface. Registered inputs provide minimal set-up and hold times on address, data, and all critical control inputs. All internal registers are clocked on the rising edge of the clock signal, however, the self-timed internal write pulse is independent of the LOW to HIGH transition of the clock signal.

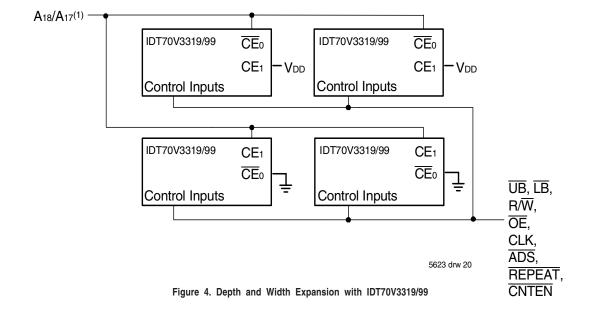
An asynchronous output enable is provided to ease asynchronous bus interfacing. Counterenable inputs are also provided to stall the operation of the address counters for fast interleaved memory applications.

A HIGH on $\overline{\text{CE}}$ or a LOW on CE1 for one clock cycle will power down the internal circuitry to reduce static power consumption. Multiple chip enables allow easier banking of multiple IDT70V3319/99s for depth expansion configurations. Two cycles are required with $\overline{\text{CE}}$ 0 LOW and CE1 HIGH to re-activate the outputs.

Depth and Width Expansion

The IDT70V3319/99 features dual chip enables (refer to Truth Table I) in order to facilitate rapid and simple depth expansion with no requirements for external logic. Figure 4 illustrates how to control the various chip enables in order to expand two devices in depth.

The IDT70V3319/99 can also be used in applications requiring expanded width, as indicated in Figure 4. Through combining the control signals, the devices can be grouped as necessary to accommodate applications needing 36-bits or wider.



NOTE:

1. A₁₇ is for IDT70V3319, A₁₆ is for IDT70V3399.

JTAG Timing Specifications

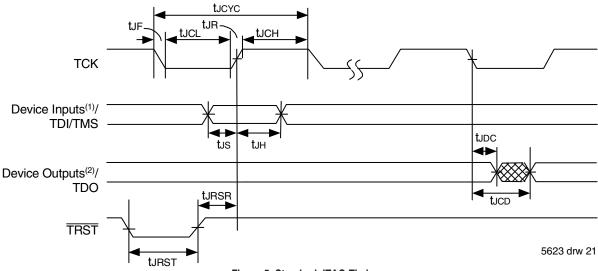


Figure 5. Standard JTAG Timing

NOTES:

- 1. Device inputs = All device inputs except TDI, TMS, and TRST.
- 2. Device outputs = All device outputs except TDO.

JTAG AC Electrical Characteristics^(1,2,3,4)

		70V3319/99		
Symbol	Parameter	Min.	Units	
tucyc	JTAG Clock Input Period	100	_	ns
tлсн	JTAG Clock HIGH	40	_	ns
tucu	JTAG Clock Low	40	_	ns
tjr	tur JTAG Clock Rise Time		3 ⁽¹⁾	ns
tur JTAG Clock Fall Time			3 ⁽¹⁾	ns
₩RST	turst JTAG Reset		_	ns
tursr	SR JTAG Reset Recovery		_	ns
tuco	tuco JTAG Data Output		25	ns
tudo	tude JTAG Data Output Hold		_	ns
tus	JTAG Setup	15		ns
tлн	tjh JTAG Hold			ns

NOTES:

5623 tbl 12

- 1. Guaranteed by design.
- 2. 30pF loading on external output signals.
- 3. Refer to AC Electrical Test Conditions stated earlier in this document.
- JTAG operations occur at one speed (10MHz). The base device may run at any speed specified in this datasheet.

Identification Register Definitions

g					
Instruction Field	Value	Description			
Revision Number (31:28) 0x0		Reserved for version number			
IDT Device ID (27:12)	0x0314 ⁽¹⁾	Defines IDT part number			
IDT JEDEC ID (11:1)	0x33	Allows unique identification of device vendor as IDT			
ID Register Indicator Bit (Bit 0)		Indicates the presence of an ID register			

NOTE: 5623 tol 13

1. Device ID for IDT70V3399 is 0x0315.

Scan Register Sizes

Register Name	Bit Size
Instruction (IR)	4
Bypass (BYR)	1
Identification (IDR)	32
Boundary Scan (BSR)	Note (3)

5623 tbl 14

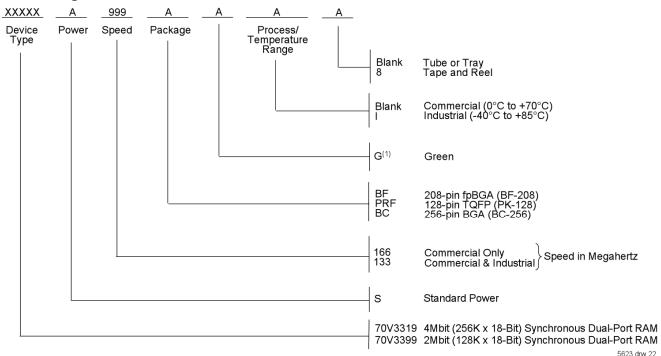
System Interface Parameters

Instruction	Code	Description
EXTEST	0000	Forces contents of the boundary scan cells onto the device outputs ⁽¹⁾ . Places the boundary scan register (BSR) between TDI and TDO.
BYPASS	1111	Places the bypass register (BYR) between TDI and TDO.
IDCODE	0010	Loads the ID register (IDR) with the vendor ID code and places the register between TDI and TDO.
HIGHZ	0011	Places the bypass register (BYR) between TDI and TDO. Forces all device output drivers to a High-Z state.
SAMPLE/PRELOAD	0001	Places the boundary scan register (BSR) between TDI and TDO. SAMPLE allows data from device inputs ⁽²⁾ to be captured in the boundary scan cells and shifted serially through TDO. PRELOAD allows data to be input serially into the boundary scan cells via the TDI.
RESERVED	All other codes	Several combinations are reserved. Do not use codes other than those identified above.

NOTES: 5623 tol 15

- 1. Device outputs = All device outputs except TDO.
- 2. Device inputs = All device inputs except TDI, TMS, and $\overline{\text{TRST}}$.
- 3. The Boundary Scan Descriptive Language (BSDL) file for this device is available on the IDT website (www.idt.com), or by contacting your local IDT sales representative.

Ordering Information



NOTE:

1. Green parts available. For specific speeds, packages and powers contact your local sales office.

IDT Clock Solution for IDT70V3319/99 Dual-Port

	Dual-Port I/O	Specitications	Clock Specifications			IDT	
IDT Dual-Port Part Number	Voltage	1/0	Input Capacitance	Input Duty Cycle Requirement	Maximum Frequency	Jitter Tolerance	PLL Clock Device
70V3319/99	3.3/2.5	LVTTL	8pF	40%	166	75ps	IDT5V2528

5623 tbl 16a

Datasheet Document History:

06/02/00: Initial Public Offering

07/12/00: Page 1 Added mux to functional block diagram 06/20/01: Page 1 Added JTAG information for TQFP package

Page 4 Corrected TQFP package size

07/30/01: Page 1 Added PL/FT option

Page 20 Changed maximum value for JTAG AC Electrical Characteristics for tucp from 20ns to 25ns

Page 9 Added Industrial Temperature DC Parameters

11/20/01: Page 2, 3 & 4 Added date revision for pin configurations

Page 11 Changed to Evalue in AC Electrical Characteristics, please refer to Errata #SMEN-01-05

Page 1 & 22 Replaced тм logo with ® logo

Page 10 Changed AC Test Conditions Input Rise/Fall Times

08/06/02: Consolidated multiple devices into one datasheet

Page 1 & 5 Added DCD capability for Pipelined Outputs

Page 7 Clarified TBIAS and added TJN
Page 9 Changed DC Electrical Parameters

Page 11 Removed Clock Rise & Fall Time from AC Electrical Characteristics Table

Removed Preliminary status

05/19/03: Page 11 Added Byte Enable SetupTime & Byte Enable Hold Time to AC Elecctrical Characteristics Table

Page 22 Added IDT Clock Solution Table

02/08/06: Page 1 Added green availability to features

Page 6 Changed footnote 2 for Truth Table I from ADS, CNTEN, REPEAT = VIH to ADS, CNTEN, REPEAT = X

Page 22 Added green indicator to ordering information

07/25/08: Page 9 Corrected a typo in the DC Chars table

01/19/09: Page 22 Removed "IDT" from orderable part number 10/03/14: Page 22 Added Tape & Reel to the Ordering Information

